

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10599531	LIU, SHENG
<b>Examiner</b>	<b>Art Unit</b>	
ANKUR JAIN	2618	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	522	12/8/2008	AJ

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched databases USPAT, US-PGPUB, EPO, JPO, DERWENT, and IBM_TDB. EAST Search History is attached.	12/8/2008	AJ

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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